

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10588701	MARUYAMA ET AL.
	<b>Examiner</b>  Mok, Alex W	<b>Art Unit</b>  2834

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
310	217	7/6/2007	AM
310	51	7/7/2007	AM
310	88	7/7/2007	AM
310	83	7/7/2007	AM
310	89	9/21/2007	AM

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	7/6/2007	AM
PLUS	9/21/2007	AM

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>